

## Ballistic transport in graphene $p$ - $n$ junctions

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$P$ - $N$  junctions in graphene promise to be a platform for investigating peculiar transport phenomena of Dirac fermions such as Klein tunneling and negative refraction. In order to observe these phenomena, we need graphene  $p$ - $n$  junctions in which the charge carrier travels ballistically. However, in the conventional graphene  $p$ - $n$  junctions, the interaction between graphene and substrate material degraded the charge carrier mobility. In this work, we fabricated high-mobility graphene  $p$ - $n$  junctions by sandwiching graphene between two hexagonal boron-nitride (h-BN) crystals. The resistivity peak as a function of back-gate bias voltage was narrow ( $\delta V_{BG}^{FWHM} \sim 1$  V), demonstrating high quality of our device. By tuning the global back gate ( $V_{BG}$ ) and local top gate ( $V_{TG}$ ), we formed  $p$ - $p'$  and  $p$ - $n$  junctions [Fig. 1]. When  $p$ - $p'$  junction was formed ( $V_{TG} = 0$  V), characteristic peak structures were emerged in bend resistance  $R_{CD,AB}$  plot [Fig. 2]. The positions of the peaks were well fitted by the curves with constant cyclotron radius  $R_c$ . This result indicates that the peak structures were caused by the charge carriers focused onto the voltage probe C from A by the ballistic carrier trajectory shown in Fig. 1. When the top gate voltage  $V_{TG}$  was varied, we observed the shift of the positions of focusing signals. We will discuss this result in terms of the change of the electron wave's refractive index at the  $p$ - $n$  junctions.

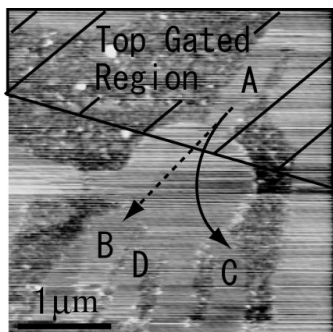


Fig. 1: AFM image of the representative device before transferring the top BN. The top gated region subsequently deposited is also depicted. The solid and dotted arrows indicate a ballistic carrier trajectory and a current direction, respectively.

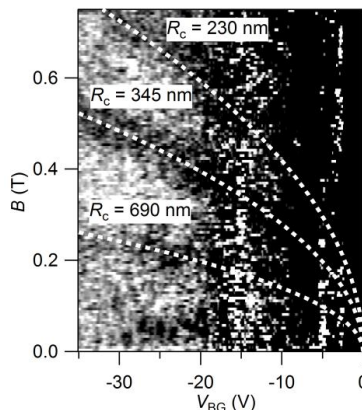


Fig. 2: Gray scale plot of bend resistance  $R_{CD,AB}$  as a function of  $V_{BG}$  and  $B$  with  $V_{TG} = 0$  V. The white dotted curves correspond to cyclotron radius  $R_c = 230, 345, 690$  nm (top to bottom), suggesting the focusing of carriers onto the voltage probe C shown in Fig. 1.

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